# **Dual N-channel MOSFET**

# KFCAB21B30L Datasheet

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#### 1. GENERAL DESCRIPTION

Gate resistor installed Dual N-channel MOSFET for lithium-ion secondary battery protection circuits.

#### 2. FEATURES

- Source-source On-state Resistance: RSS(on) typ = 2.2 m $\Omega$  (VGS = 3.8 V)
- · CSP (Chip Size Package)
- Halogen-free / RoHS compliant (EU RoHS / UL-94 V-0 / MSL: Level 1)

#### 3. MARKING SYMBOL: UP

# 4. PACKAGING

Embossed type (Thermo-compression sealing): 10,000 pcs / reel (standard)

# 5. ABSOLUTE MAXIMUM RATINGS Ta = 25 °C

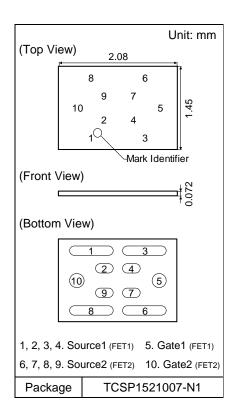
Parameter		Symbol	Rating	Unit	
Source-source Voltage		VSS	12	V	
Gate-source Voltage		VGS	± 8	V	
	DC *1	IS1	14.6		
Source Current	DC *2	IS2	23.0	^	
	DC *3	IS3	31.0	А	
	Pulsed*4	ISp	146		
	DC *1	PD1	0.61		
Total Power Dissipation	DC *2	PD2	1.60	W	
	DC *3	PD3	2.80		
Operating Junction and Storage Temperature Range		Tj, Tstg	- 55 to + 150	°C	

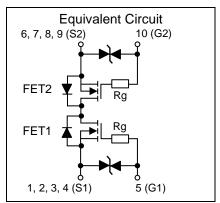
# 6. THERMAL CHARACTERISTICS Ta = 25 °C

Parameter	Symbol	Rating	Unit	
	Rth1 *1	205		
Thermal Resistance (ch-a)	Rth2 *2	79	°C/W	
	Rth3 *3	45		

Note \*1 Mounted on FR4 board (25.4 mm x 25.4 mm x t1.0 mm). FR4 board partially covered with copper pad (60 mm² area, 36 µm thickness).

- \*2 Mounted on FR4 board (25.4 mm x 25.4 mm x t1.0 mm). FR4 board fully covered with copper pad (611 mm² area, 36 µm thickness).
- \*3 Mounted on ceramic board (70 mm x 70 mm x t1.0 mm).
- \*4  $t = 10 \mu s$ , Duty Cycle  $\leq 1 \%$ .





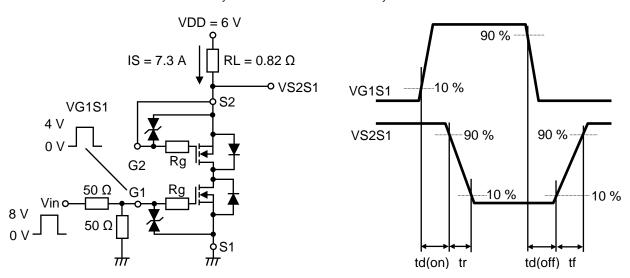


# 7. ELECTRICAL CHARACTERISTICS Ta = 25 °C ± 3 °C

Parameter	Symbol	Conditions	Min	Тур	Max	Unit	
Source-source Breakdown Voltage	VSSS	IS = 1 mA, VGS = 0 V	12			V	
Zero Gate Voltage Source Current	ISSS	VSS = 12 V, VGS = 0 V			1	μΑ	
Cata assumed Lankage Comment	IGSS1	VGS = ± 8 V, VSS = 0 V			± 10		
Gate-source Leakage Current	IGSS2	VGS = ± 5 V, VSS = 0 V			± 1	μA	
Gate-source Threshold Voltage	Vth	IS = 0.46 mA, VSS = 6 V	0.35	0.90	1.40	V	
	RSS(on)1	IS = 7.3 A, VGS = 4.5 V	1.50	2.05	2.70	85 mΩ	
Course course On state Besistenes	RSS(on)2	IS = 7.3 A, VGS = 3.8 V	1.60	2.20	2.85		
Source-source On-state Resistance	RSS(on)3	IS = 7.3 A, VGS = 3.1 V	1.75	2.55	3.90		
	RSS(on)4	IS = 7.3 A, VGS = 2.5 V	2.00	3.30	6.60		
Body Diode Forward Voltage	VF(s-s)	IF = 7.3 A, VGS = 0 V		0.71	1.00	V	
Input Capacitance *1	Ciss			3490			
Output Capacitance *1	Coss	VSS = 10 V, VGS = 0 V, f = 1 kHz		425		pF	
Reverse Transfer Capacitance *1	Crss			360			
Turn-on Delay Time *1,*2	td(on)	VDD = 6 V, VGS = 0 to 4 V		1.0			
Rise Time *1, *2	tr	IS = 7.3 A		1.6		μs	
Turn-off Delay Time *1,*2	td(off)	VDD = 6 V, VGS = 4 to 0 V		6.1			
Fall Time *1, *2	tf	IS = 7.3 A		2.8		μs	
Total Gate Charge *1	Qg	VDD = 6 V		32			
Gate-source Charge *1	Qgs	VGS = 0 to 4 V		7		nC	
Gate-drain Charge *1	Qgd	IS = 14.6 A		6			
Gate Resistance *1	Rg	f = 1 MHz	400	700	1000	Ω	

Note Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 Measuring methods for transistors.

- \*1 Guaranteed by design, not subject to production testing.
- \*2 Measurement circuit for Turn-on Delay Time / Rise Time / Turn-off Delay Time / Fall Time.

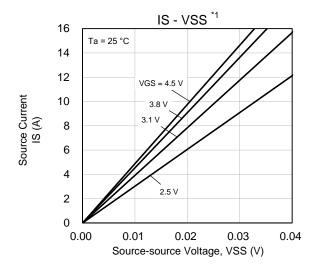


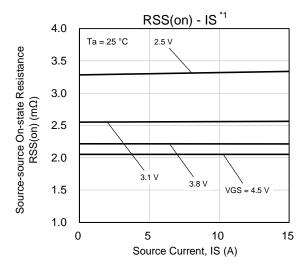
# 8. ELECTROSTATIC DISCHARGE CHARACTERISTIC Ta = 25 °C ± 3 °C

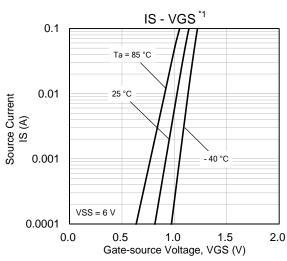
Standard	Test Type	Symbol	Conditions	Class	Value	Unit
AEC-Q101-001	Human Body Model	HBM	$C = 100 \text{ pF}, R = 1.5 \text{ k}\Omega$	H2	> 2 to ≤ 4	kV

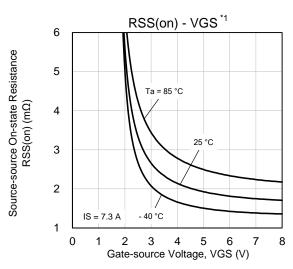


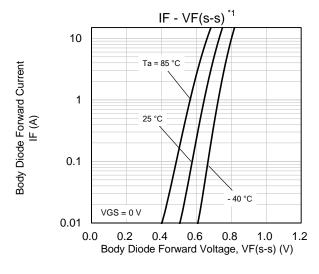
# 9. TECHNICAL DATA (Reference)

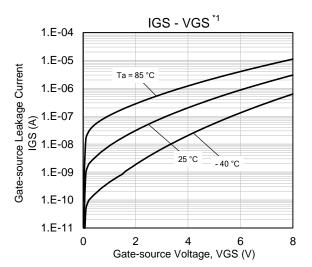






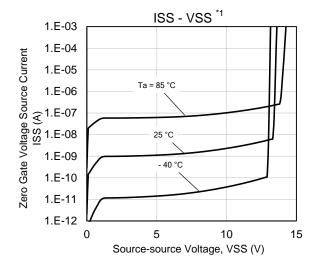


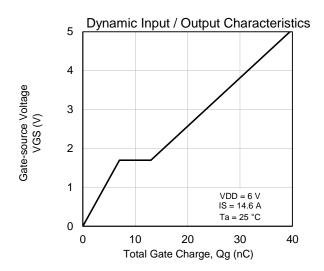


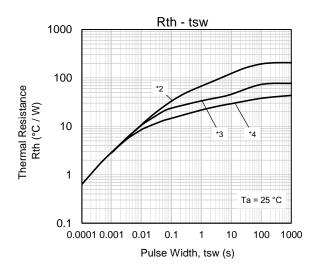


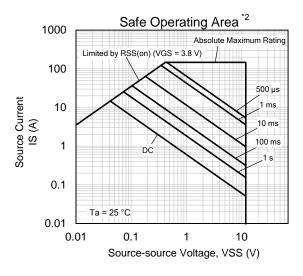


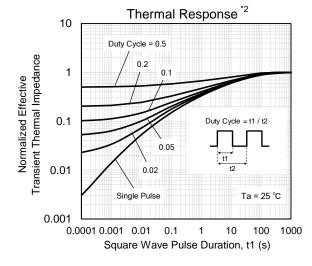
# **TECHNICAL DATA (Reference)**









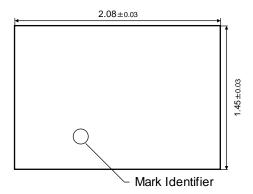


#### Note

- \*1 Pulse measurement.
- \*2 Mounted on FR4 board (25.4 mm  $\times$  25.4 mm  $\times$  t1.0 mm). FR4 board partially covered with copper pad (60 mm<sup>2</sup> area, 36  $\mu$ m thickness).
- \*3 Mounted on FR4 board (25.4 mm  $\times$  25.4 mm  $\times$  t1.0 mm). FR4 board fully covered with copper pad (611 mm<sup>2</sup> area, 36  $\mu$ m thickness).
- \*4 Mounted on ceramic board (70 mm  $\times$  70 mm  $\times$  t1.0 mm).



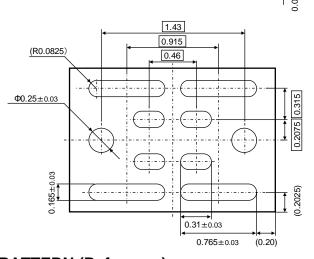
(Top View)



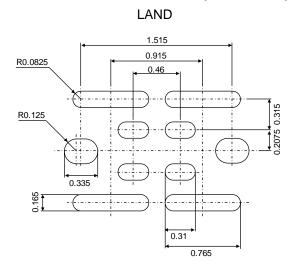
Unit: mm

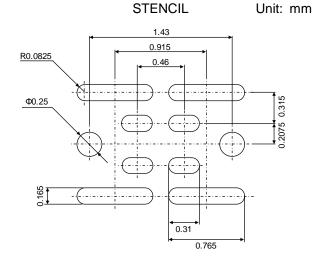
(Front View)

(Bottom View)



# 11. LAND & STENCIL PATTERN (Reference)





#### Important notice:

Solder Mask Defined (SMD) pattern is strongly recommended for pad design. Please check the information in the Nuvoton WL-CSP Application Notes about mounting process.



# 12. REVISION HISTORY

Date	Revision	Description
2021.9.16	1.00	1. Initially issued.



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